

## Tentative

## CM150TL-24NF

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HIGH POWER SWITCHING USE

Notice : This is not a final specification. Some parametric limits are subject to change.

CM150TL-24NF
● $I_c$ .....150A
● $V_{CES}$ .....1200V
●Insulated Type
●6-elements in a pack

## APPLICATION

AC drive inverters &amp; Servo controls,etc

ABSOLUTE MAXIMUM RATINGS ( $T_j = 25^\circ\text{C}$ )

Symbol	Item	Conditions	Ratings	Units
$V_{CES}$	Collector-emitter voltage	G-E Short	1200	V
$V_{GES}$	Gate-emitter voltage	C-E Short	$\pm 20$	
$I_c$	Collector current	DC, $T_c = 76^\circ\text{C}^{*1}$	150	A
$I_{CM}$		Pulse ②	300	
$I_E$ ①		Emitter current		
$I_{EM}$ ①	Pulse ②		300	
$P_c$ ③	Maximum collector dissipation	$T_c = 25^\circ\text{C}$	890	W
$T_j$	Junction temperature		$-40 \sim +150$	$^\circ\text{C}$
$T_{stg}$	Storage temperature		$-40 \sim +125$	
Viso	Isolation voltage	Main terminal to base plate, AC 1 min.	2500	V
—	Torque strength	Main terminal M5	2.5~3.5	N·m
—	Torque strength	Mounting holes M5	2.5~3.5	
—	Weight	Typical value	750	

ELECTRICAL CHARACTERISTICS ( $T_j = 25\text{ }^\circ\text{C}$ )

Symbol	Item	Conditions	Min.	Typ.	Max.	Units		
$I_{CES}$	Collector cutoff current	$V_{CE}=V_{CES}, V_{GE}=0V$	—	—	1	mA		
$V_{GE(th)}$	Gate-emitter threshold voltage	$I_C=15mA, V_{CE}=10V$	6	7	8	V		
$I_{GES}$	Gate leakage current	$V_{GE}=V_{GES}, V_{CE}=0V$	—	—	0.5	$\mu A$		
$V_{CE(sat)}$	Collector to emitter saturation voltage	$I_C=150A$ $V_{GE}=15V$	$T_j=25\text{ }^\circ\text{C}$	—	2.1	3.0	V	
			$T_j=125\text{ }^\circ\text{C}$	—	2.4	—		
$C_{ies}$	Input capacitance	$V_{CE}=10V$ $V_{GE}=0V$	—	—	23	nF		
$C_{oes}$	Output capacitance		—	—	2			
$C_{res}$	Reverse transfer capacitance		—	—	0.45			
$Q_G$	Total gate charge	$V_{CC}=600V, I_C=150A, V_{GE}=15V$	—	675	—	nC		
$t_d(on)$	Turn-on delay time	$V_{CC}=600V, I_C=150A$ $V_{GE1}=V_{GE2}=15V$ $R_G=2.1\ \Omega$ , Inductive load switching operation	—	—	130	ns		
$t_r$	Turn-on rise time		—	—	70			
$t_d(off)$	Turn-off delay time		—	—	400		A	
$t_f$	Turn-off fall time		—	—	350			
$t_{rr}$ ①	Reverse recovery time		$I_E=150A$	—	—		150	
$Q_{rr}$ ①	Reverse recovery charge	—		5.8	—	$\mu C$	A	
$V_{EC}$ ①	Emitter-collector voltage	$I_E=150A, V_{GE}=0V$	—	—	3.8	V		
$R_{th(j-c)Q}$	Thermal resistance	IGBT part (1/6 module) *1	—	—	0.14	$^\circ\text{C/W}$		
$R_{th(j-c)R}$	Thermal resistance	FWDi part (1/6 module) *1	—	—	0.23			
$R_{th(c-f)}$	Contact thermal resistance	Case to fin, Thermal compound Applied (1/6 module) *2	—	0.051	—		B	
$R_G$	External gate resistance		2.1	—	31	$\Omega$		

\*1:  $T_c$  measured point is just under the chips.

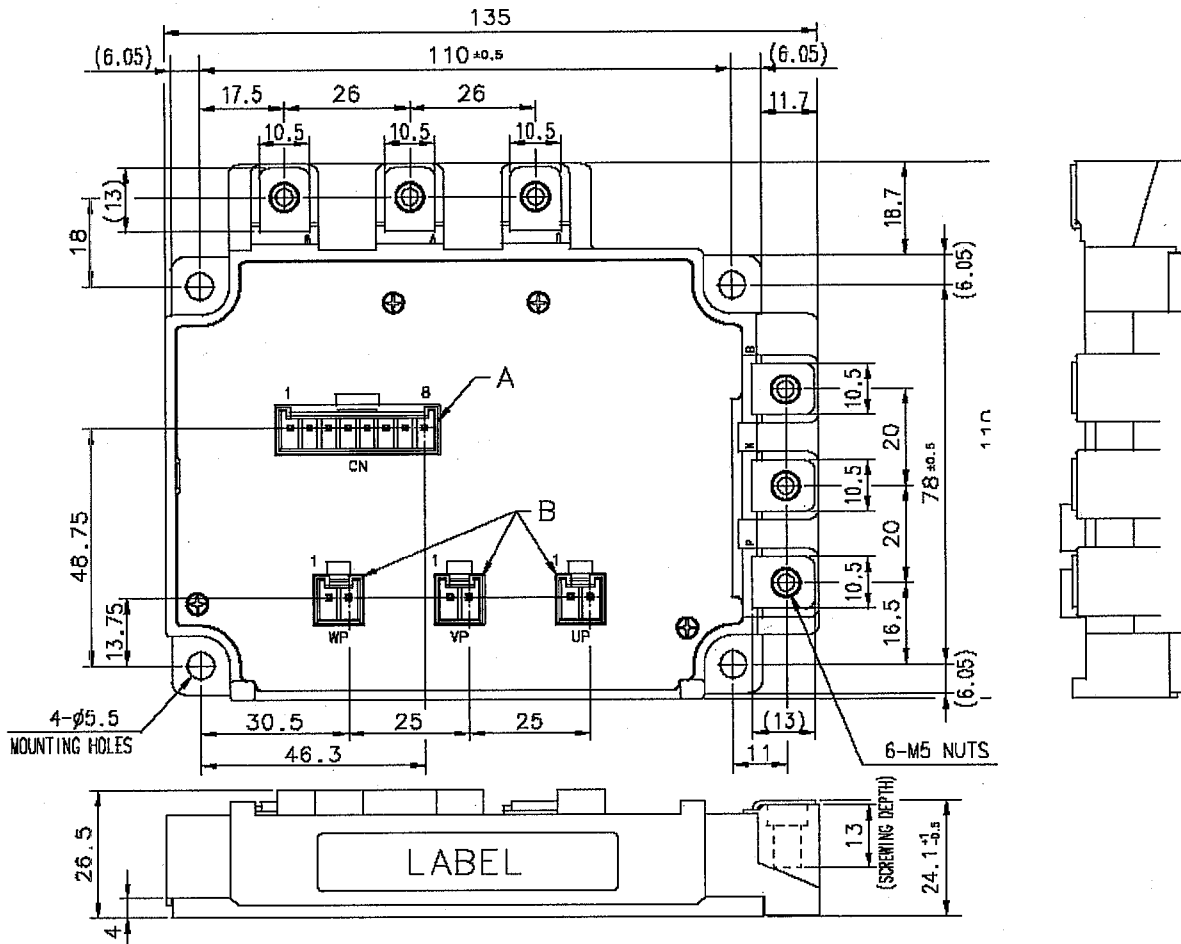
If you use this value,  $R_{th(f-a)}$  should be measured just under the chips.

\*2: Typical value is measured by using Shin-etsu Silicone "G-746".

- ①  $I_E, V_{EC}, t_{rr}, Q_{rr}$  represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).
- ② Pulse width and repetition rate should be such that the device junction temp. ( $T_j$ ) does not exceed  $T_{jmax}$  rating.
- ③ Junction temperature ( $T_j$ ) should not increase beyond  $150^\circ\text{C}$ .
- ④ Pulse width and repetition rate should be such as to cause negligible temperature rise.

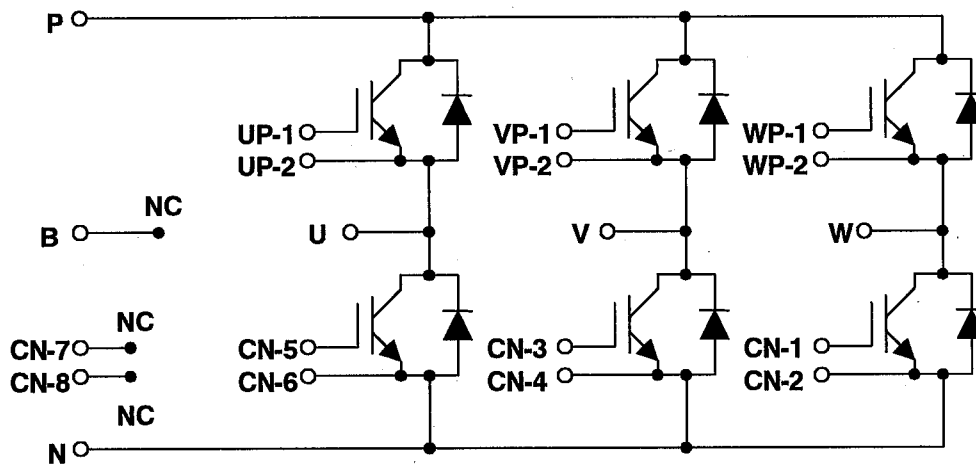
OUTLINE DRAWING

Dimensions in mm



Housing Type of A and B  
 (J.S.T.Mfg.Co.Ltd)  
 A= B8P-VH-FB-B, B= B2P-VH-FB-B

CIRCUIT DIAGRAM



CHIP LAYOUT DRAWING

Dimensions in mm

